

NSBC114EPDXV6T1, NSBC114EPDXV6T5

ELECTRICAL CHARACTERISTICS

($T_A = 25^\circ\text{C}$ unless otherwise noted, common for Q_1 and Q_2 , - minus sign for Q_1 (PNP) omitted)

Characteristic	Symbol	Min	Typ	Max	Unit
ON CHARACTERISTICS (Note 3)					
Output Voltage (on) ($V_{CC} = 5.0 \text{ V}$, $V_B = 2.5 \text{ V}$, $R_L = 1.0 \text{ k}\Omega$) ($V_{CC} = 5.0 \text{ V}$, $V_B = 3.5 \text{ V}$, $R_L = 1.0 \text{ k}\Omega$)	V_{OL}	-	-	0.2	Vdc
NSBC114EPDXV6T1 NSBC124EPDXV6T1 NSBC114YPDXV6T1 NSBC114TPDXV6T1 NSBC143TPDXV6T1 NSBC113EPDXV6T1 NSBC123EPDXV6T1 NSBC143EPDXV6T1 NSBC143ZPDGX6T1 NSBC124XPDXV6T1 NSBC123JPDXV6T1 NSBC144EPDXV6T1				0.2	
Output Voltage (off) ($V_{CC} = 5.0 \text{ V}$, $V_B = 0.5 \text{ V}$, $R_L = 1.0 \text{ k}\Omega$) ($V_{CC} = 5.0 \text{ V}$, $V_B = 0.050 \text{ V}$, $R_L = 1.0 \text{ k}\Omega$) ($V_{CC} = 5.0 \text{ V}$, $V_B = 0.25 \text{ V}$, $R_L = 1.0 \text{ k}\Omega$)	V_{OH}	4.9	-	-	Vdc
NSBC113EPDXV6T1 NSBC114TPDXV6T1 NSBC143TPDXV6T1 NSBC143ZPDGX6T1					
Input Resistor	$R1$	7.0 15.4 32.9 7.0 7.0 3.3 0.7 1.5 3.3 3.3 15.4 1.54	10 22 47 10 10 4.7 1.0 2.2 4.7 4.7 22 2.2	13 28.6 61.1 13 13 6.1 1.3 2.9 6.1 6.1 28.6 2.86	$\text{k } \Omega$
Resistor Ratio NSBC114EPDXV6T1/NSBC124EPDXV6T1/NSBC144EPDXV6T1 NSBC114YPDXV6T1 NSBC114TPDXV6T1/NSBC143TPDXV6T1 NSBC113EPDXV6T1/NSBC123EPDXV6T1/NSBC143EPDXV6T1 NSBC143ZPDGX6T1 NSBC124XPDXV6T1 NSBC123JPDXV6T1	$R1/R2$	0.8 0.17 - 0.8 0.055 0.38 0.038	1.0 0.21 - 1.0 0.1 0.47 0.047	1.2 0.25 - 1.2 0.185 0.56 0.056	

2. New resistor combinations. Updated curves to follow in subsequent data sheets.
3. Pulse Test: Pulse Width < 300 μs , Duty Cycle < 2.0%
4. Available upon request.

NSBC114EPDXV6T1, NSBC114EPDXV6T5

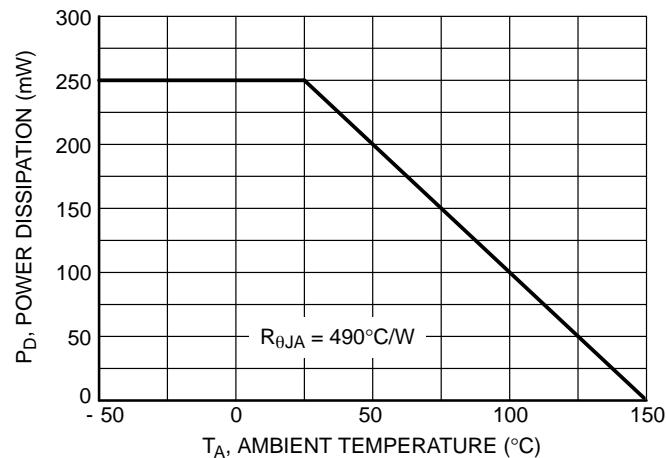


Figure 1. Derating Curve

NSBC114EPDXV6T1, NSBC114EPDXV6T5

TYPICAL ELECTRICAL CHARACTERISTICS - NSBC114EPDXV6T1 NPN TRANSISTOR

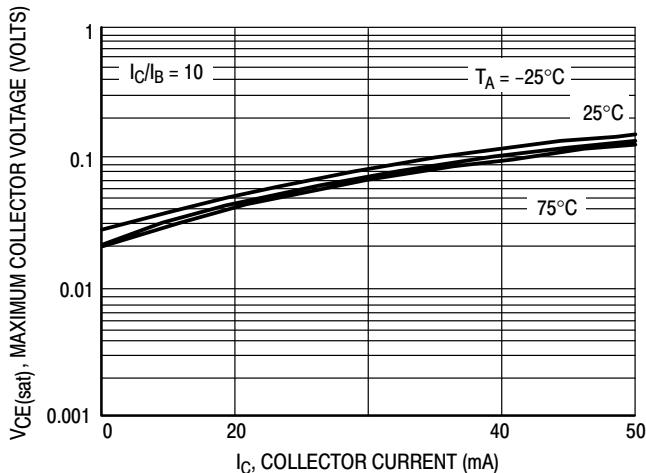


Figure 2. $V_{CE(sat)}$ versus I_C

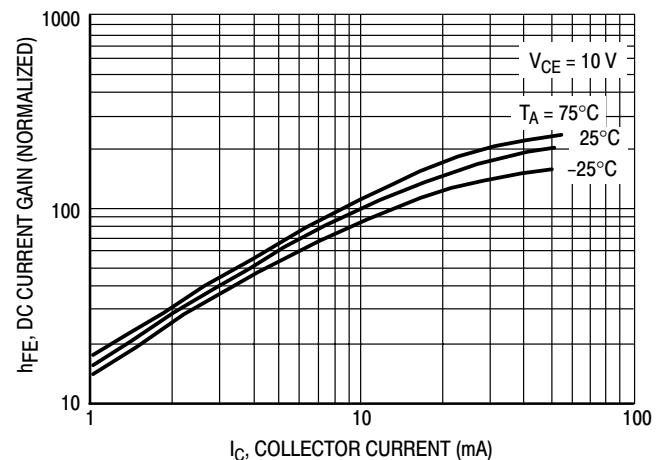


Figure 3. DC Current Gain

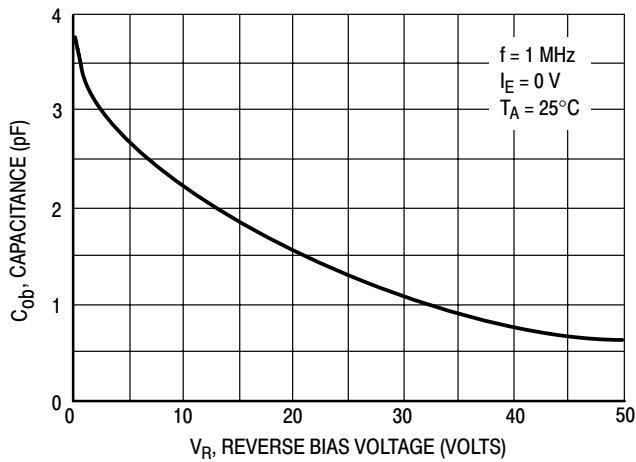


Figure 4. Output Capacitance

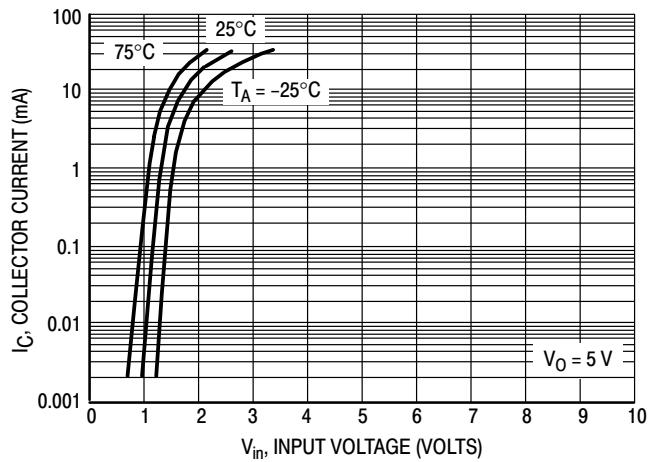


Figure 5. Output Current versus Input Voltage

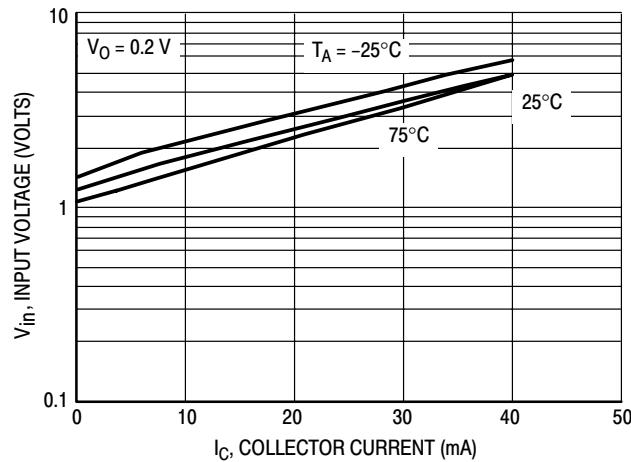


Figure 6. Input Voltage versus Output Current

NSBC114EPDXV6T1, NSBC114EPDXV6T5

TYPICAL ELECTRICAL CHARACTERISTICS - NSBC114EPDXV6T1 PNP TRANSISTOR

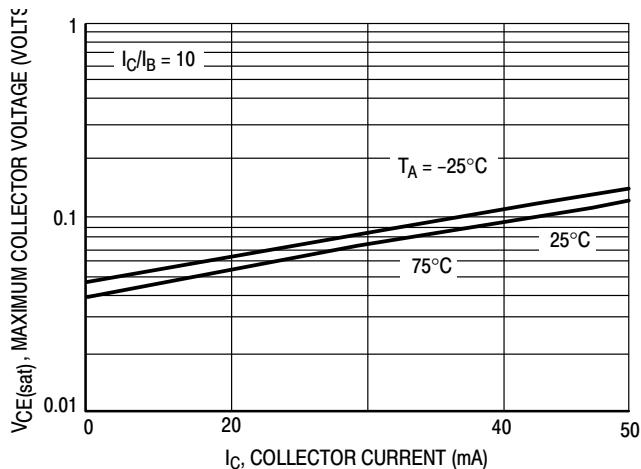


Figure 7. $V_{CE(sat)}$ versus I_C

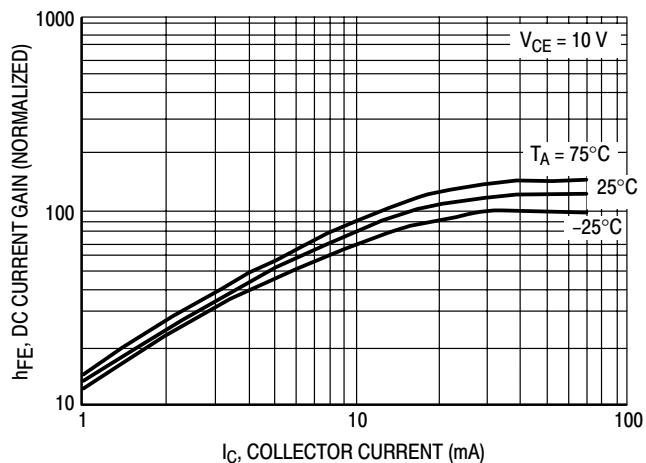


Figure 8. DC Current Gain

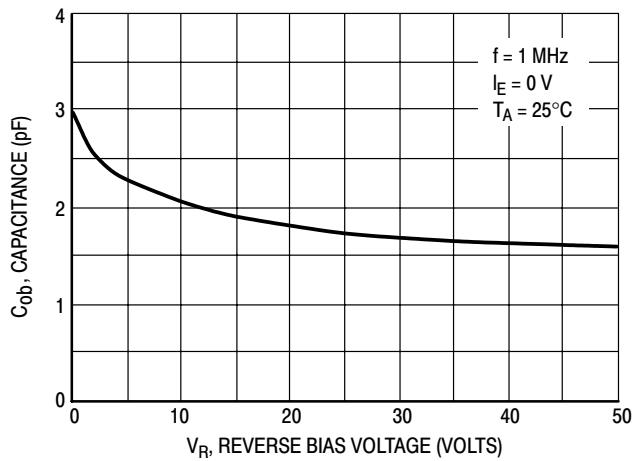


Figure 9. Output Capacitance

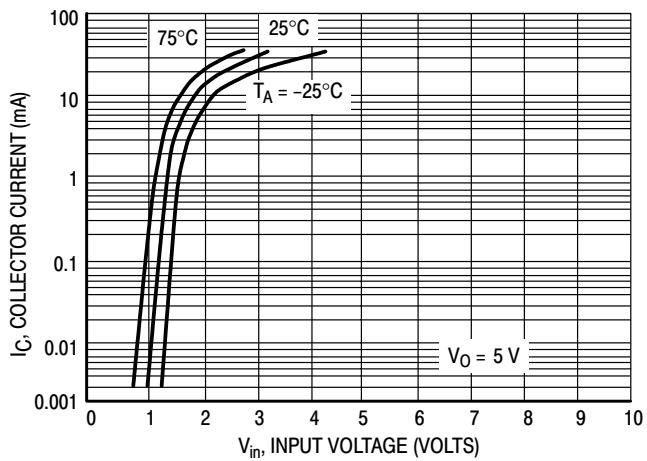


Figure 10. Output Current versus Input Voltage

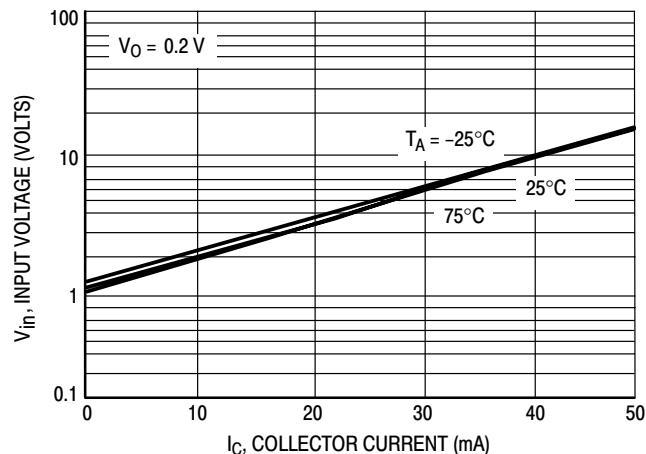


Figure 11. Input Voltage versus Output Current

NSBC114EPDXV6T1, NSBC114EPDXV6T5

TYPICAL ELECTRICAL CHARACTERISTICS - NSBC124EPDXV6T1 NPN TRANSISTOR

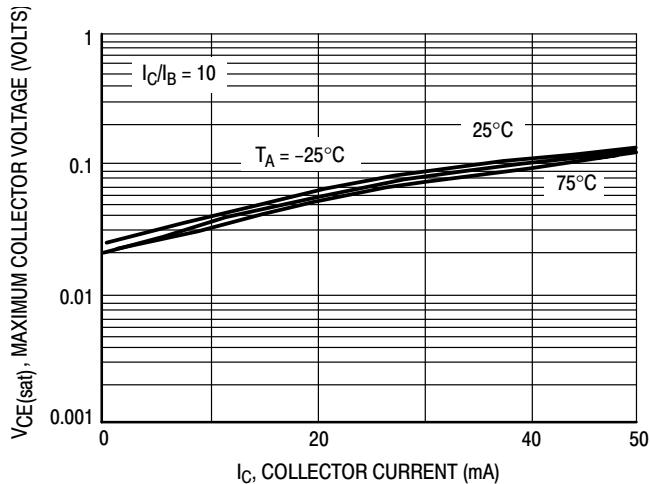


Figure 12. $V_{CE(sat)}$ versus I_C

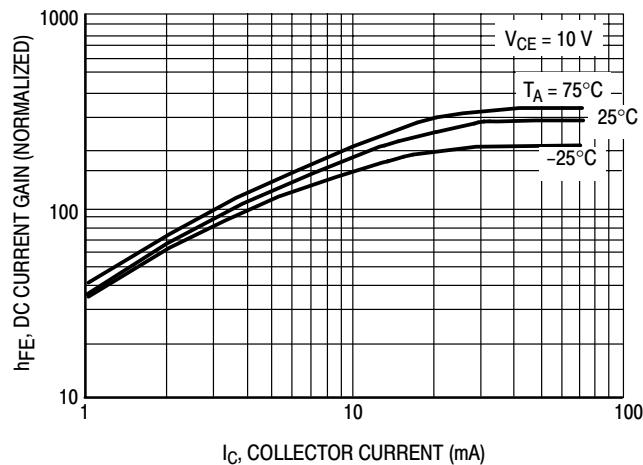


Figure 13. DC Current Gain

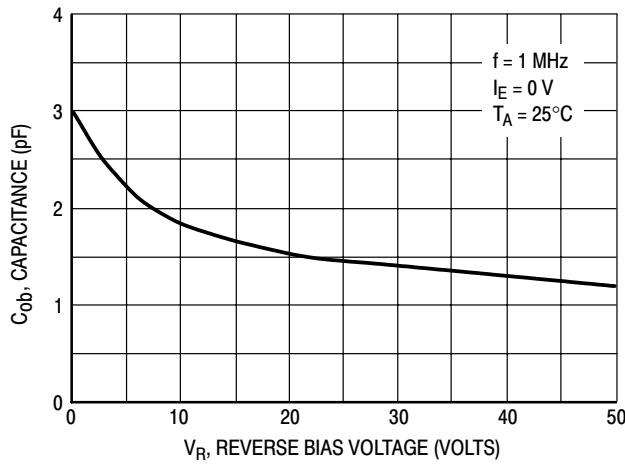


Figure 14. Output Capacitance

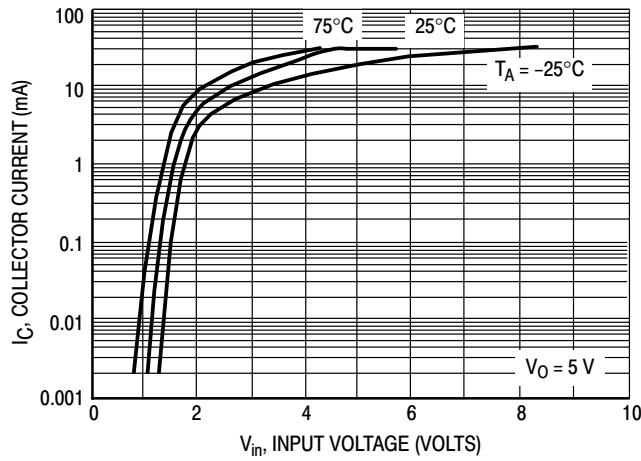


Figure 15. Output Current versus Input Voltage

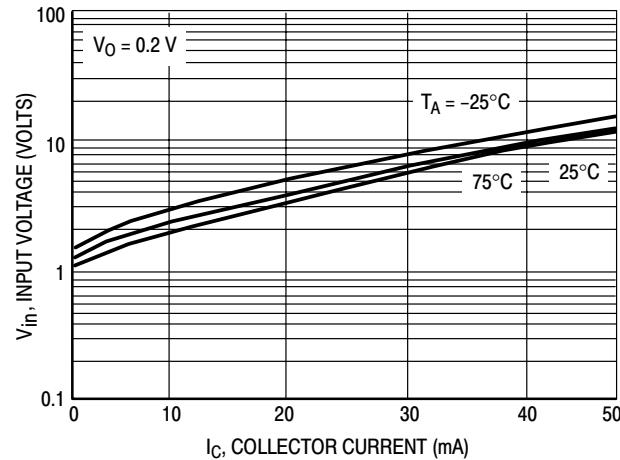


Figure 16. Input Voltage versus Output Current

NSBC114EPDXV6T1, NSBC114EPDXV6T5

TYPICAL ELECTRICAL CHARACTERISTICS - NSBC124EPDXV6T1 PNP TRANSISTOR

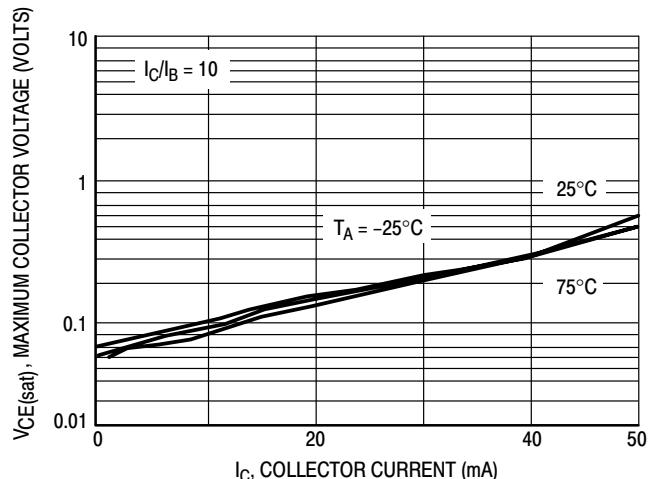


Figure 17. $V_{CE(sat)}$ versus I_C

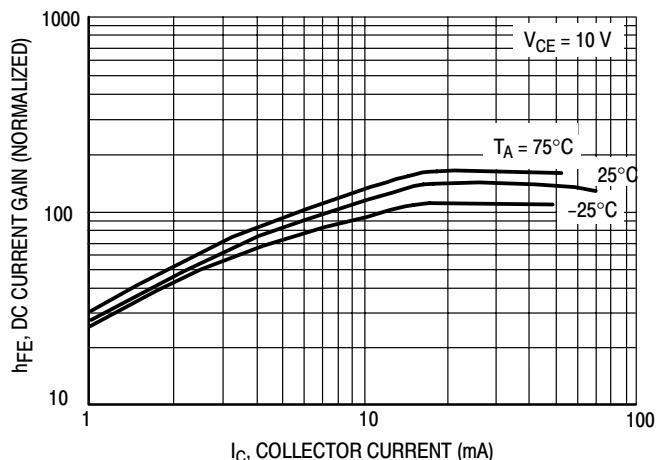


Figure 18. DC Current Gain

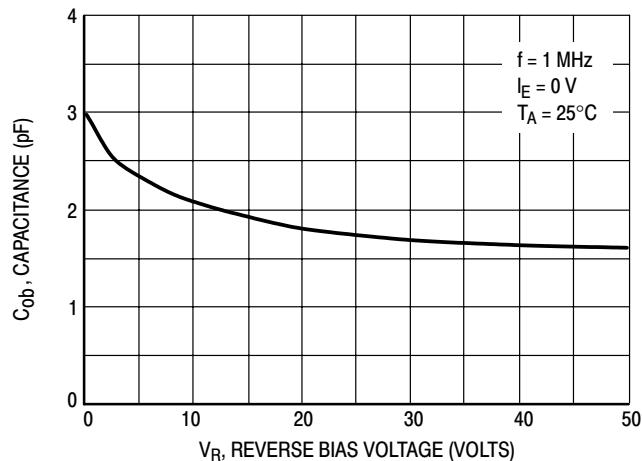


Figure 19. Output Capacitance

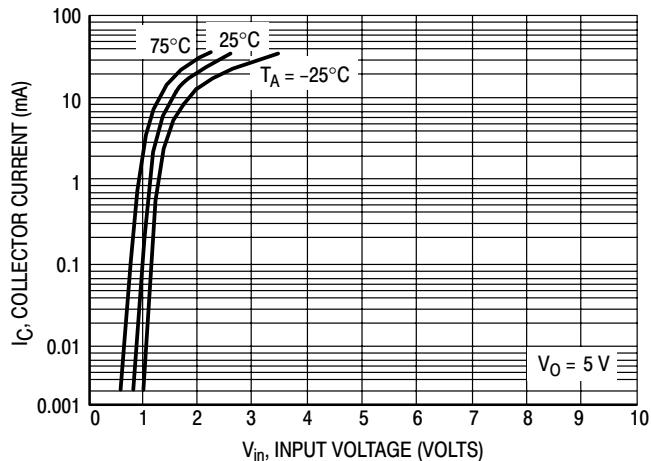


Figure 20. Output Current versus Input Voltage

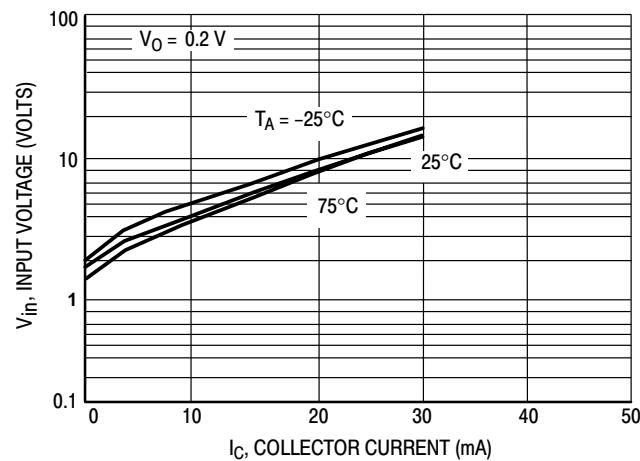


Figure 21. Input Voltage versus Output Current

NSBC114EPDXV6T1, NSBC114EPDXV6T5

TYPICAL ELECTRICAL CHARACTERISTICS - NSBC114EPDXV6T1 NPN TRANSISTOR

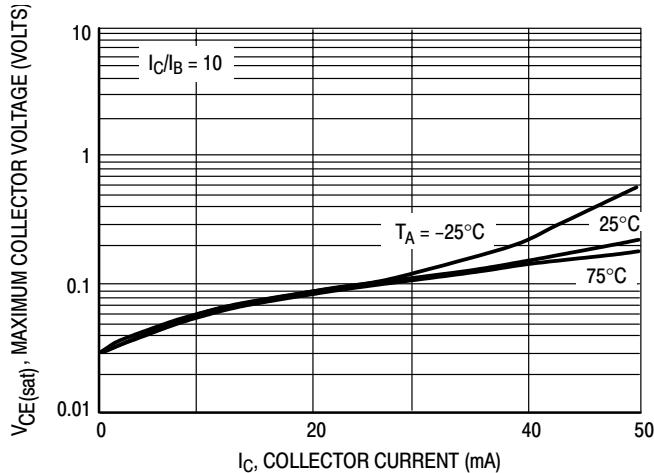


Figure 22. $V_{CE(sat)}$ versus I_C

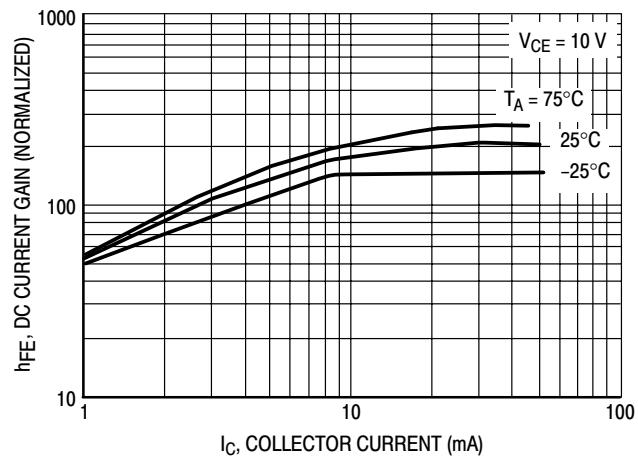


Figure 23. DC Current Gain

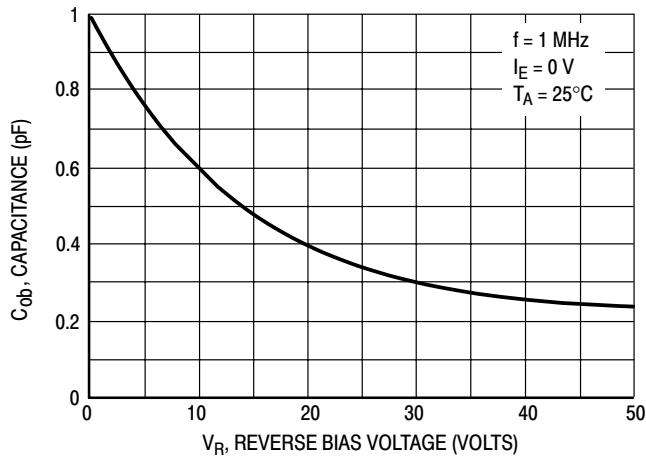


Figure 24. Output Capacitance

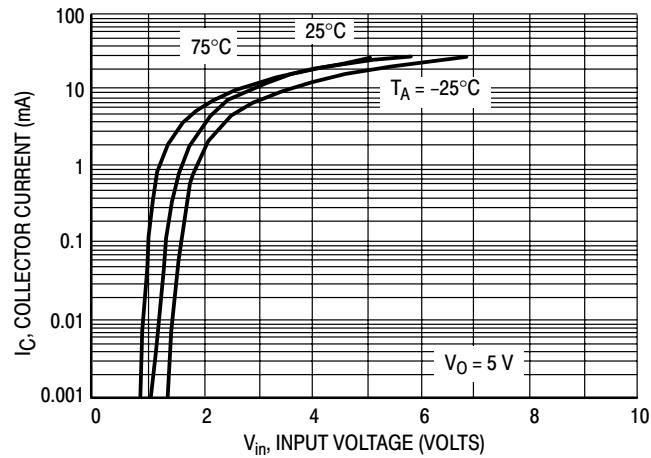


Figure 25. Output Current versus Input Voltage

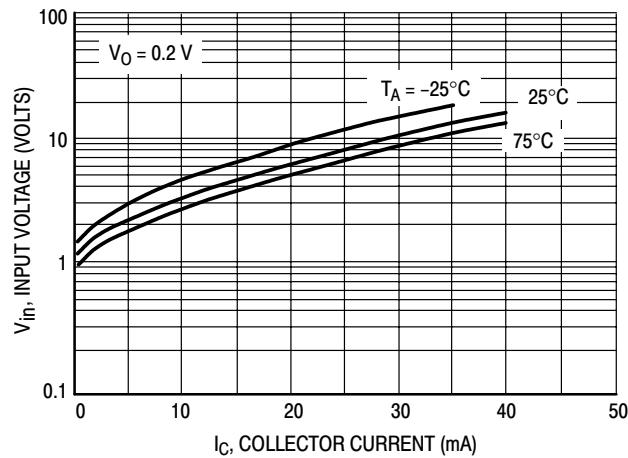


Figure 26. Input Voltage versus Output Current

NSBC114EPDXV6T1, NSBC114EPDXV6T5

TYPICAL ELECTRICAL CHARACTERISTICS - NSBC114EPDXV6T1 PNP TRANSISTOR

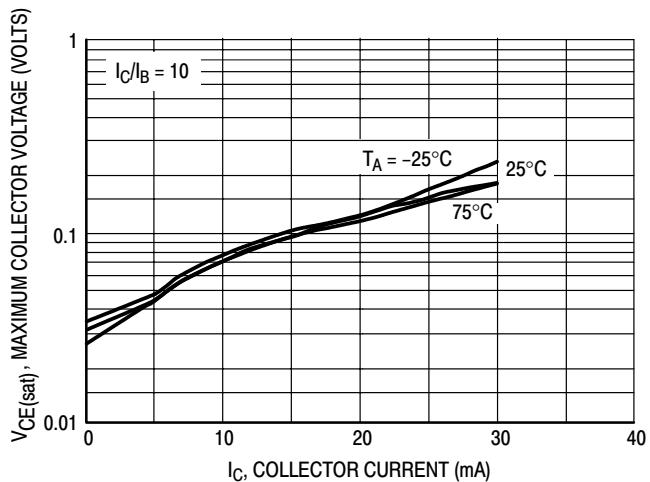


Figure 27. $V_{CE(sat)}$ versus I_C

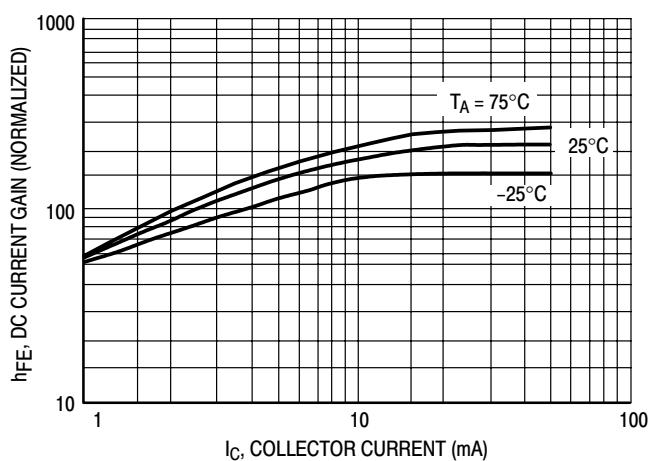


Figure 28. DC Current Gain

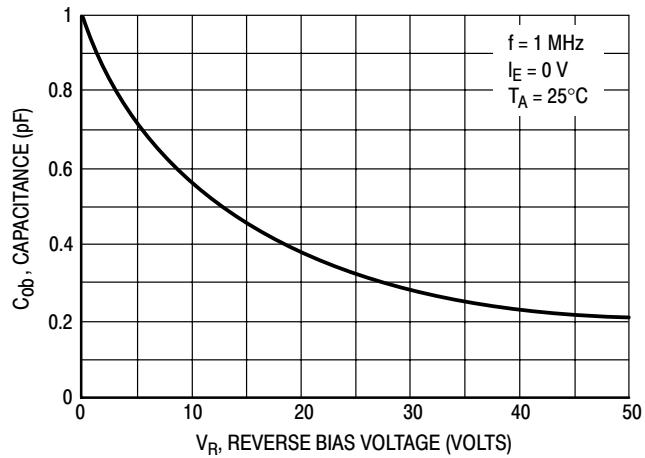


Figure 29. Output Capacitance

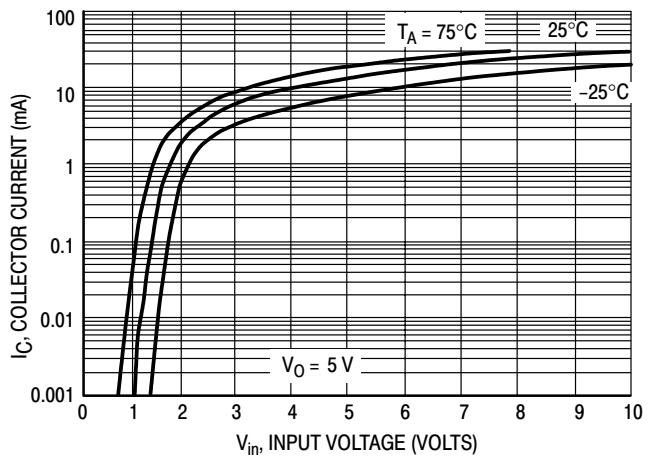


Figure 30. Output Current versus Input Voltage

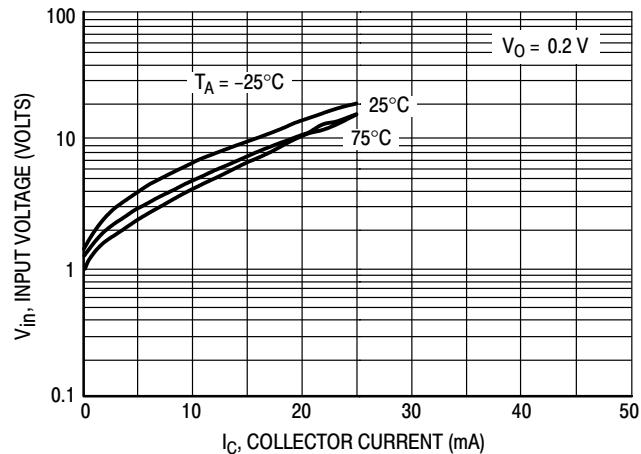


Figure 31. Input Voltage versus Output Current

NSBC114EPDXV6T1, NSBC114EPDXV6T5

TYPICAL ELECTRICAL CHARACTERISTICS - NSBC114YPDXV6T1 NPN TRANSISTOR

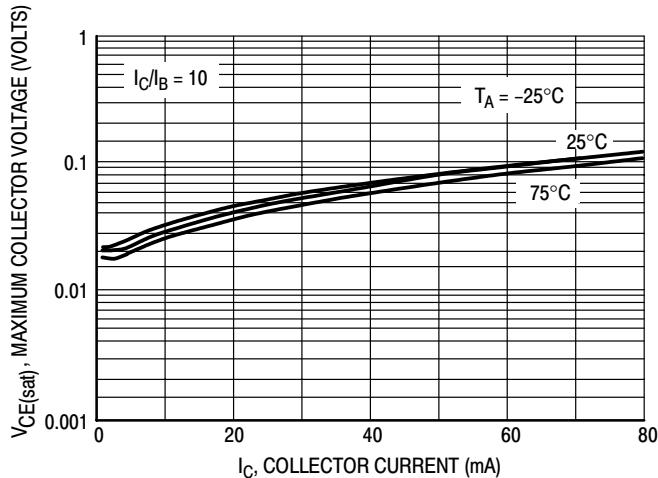


Figure 32. $V_{CE(\text{sat})}$ versus I_C

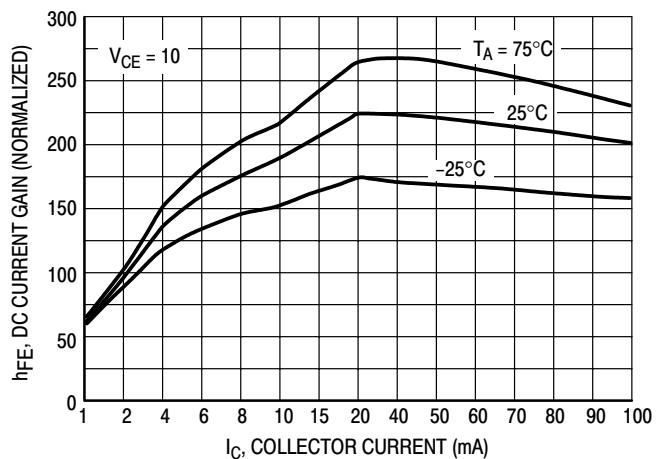


Figure 33. DC Current Gain

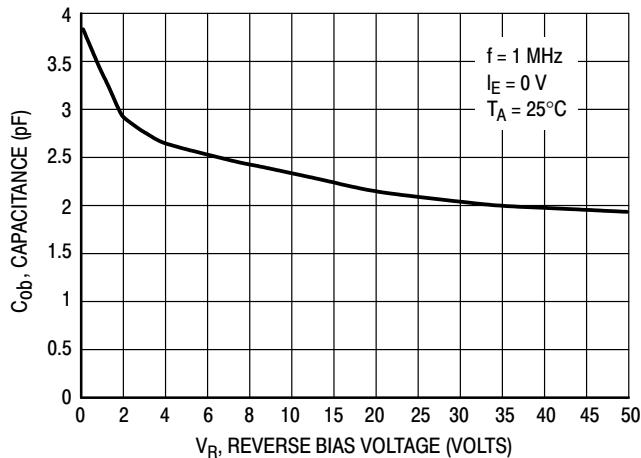


Figure 34. Output Capacitance

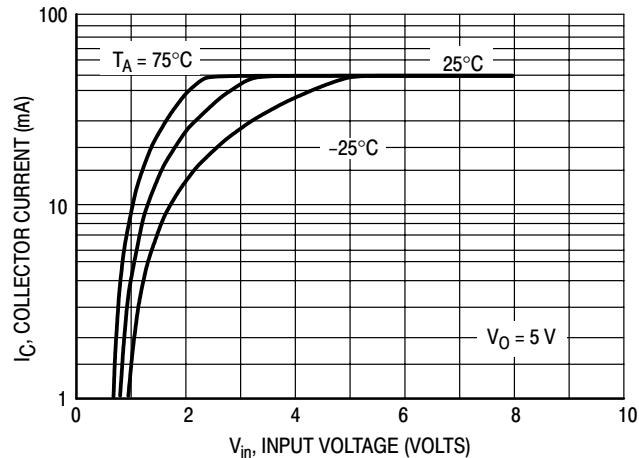


Figure 35. Output Current versus Input Voltage

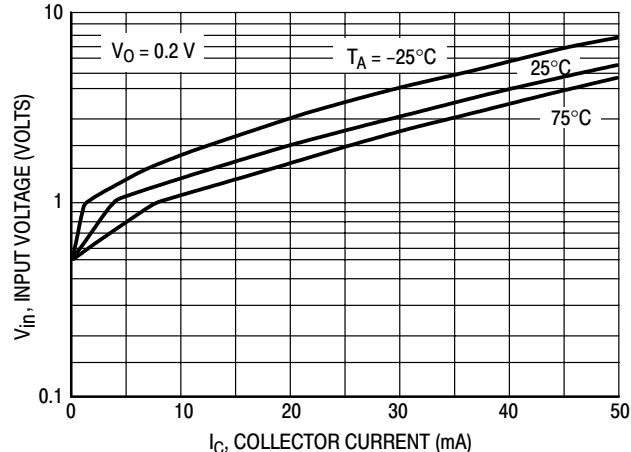


Figure 36. Input Voltage versus Output Current

NSBC114EPDXV6T1, NSBC114EPDXV6T5

TYPICAL ELECTRICAL CHARACTERISTICS - NSBC114YPDXV6T1 PNP TRANSISTOR

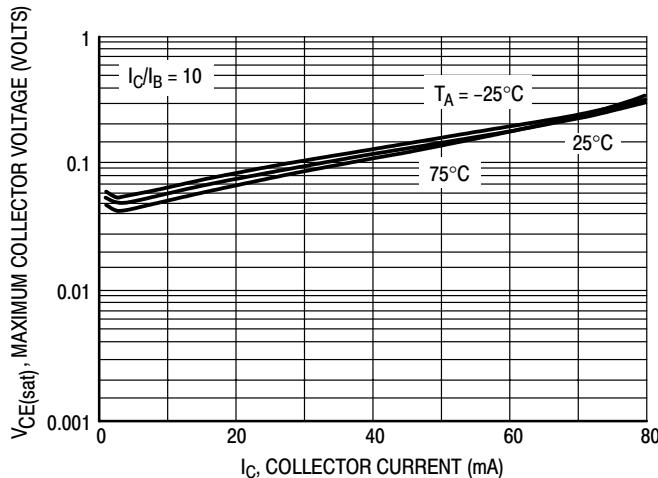


Figure 37. $V_{CE(sat)}$ versus I_C

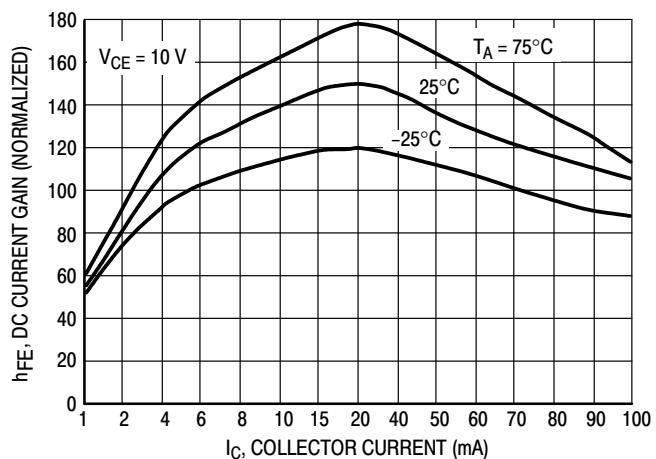


Figure 38. DC Current Gain

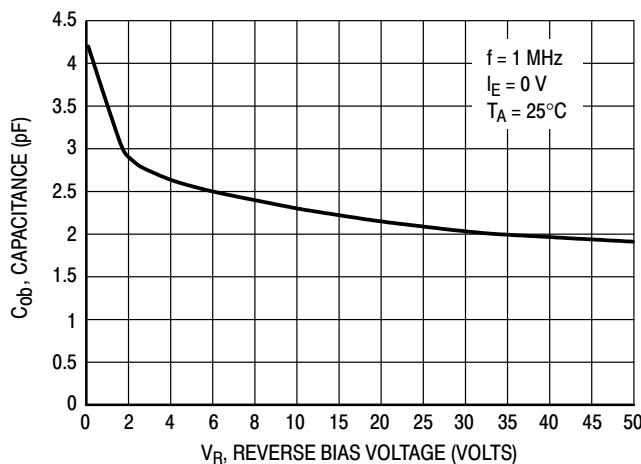


Figure 39. Output Capacitance

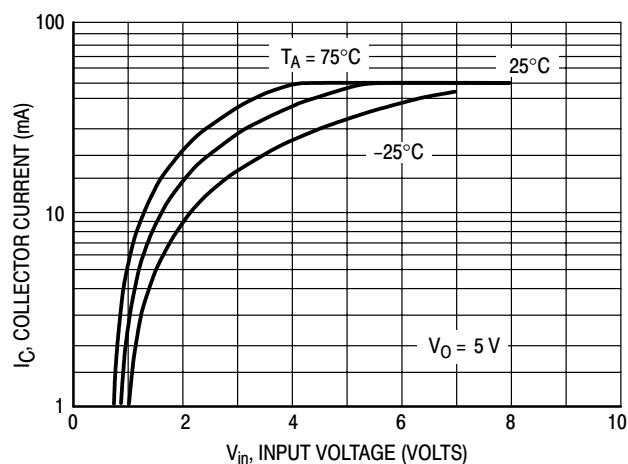


Figure 40. Output Current versus Input Voltage

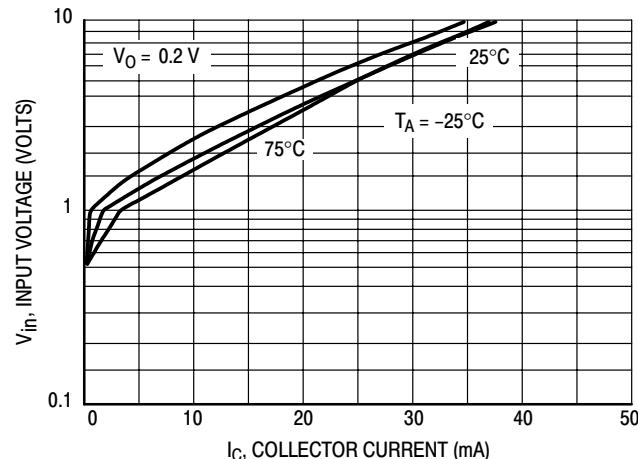


Figure 41. Input Voltage versus Output Current

NSBC114EPDXV6T1, NSBC114EPDXV6T5

TYPICAL ELECTRICAL CHARACTERISTICS - NSBC114TPDXV6T1

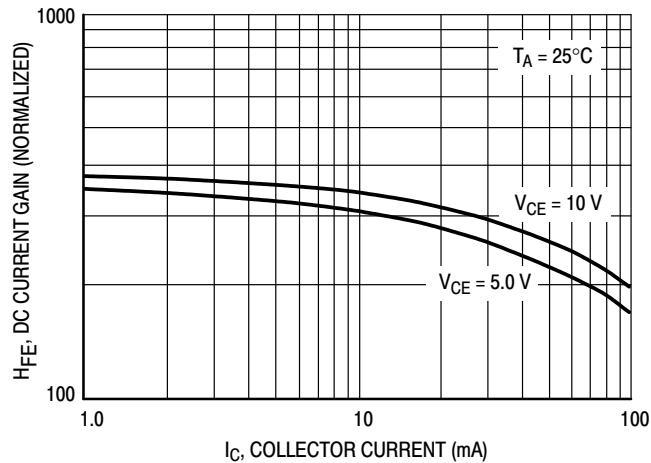


Figure 42. DC Current Gain - PNP

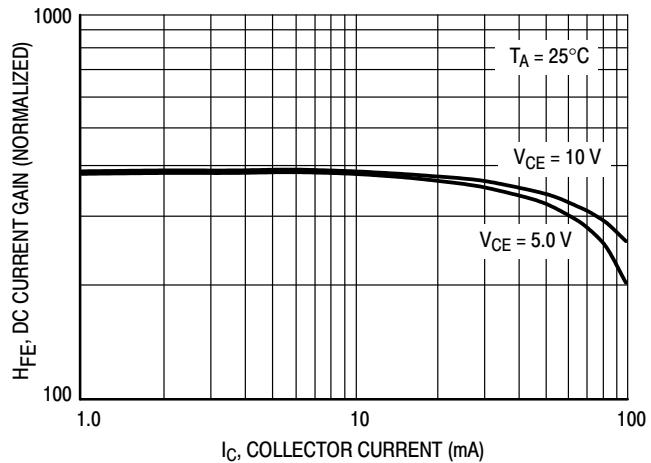


Figure 43. DC Current Gain - NPN

TYPICAL ELECTRICAL CHARACTERISTICS - NSBC143TPDXV6T1

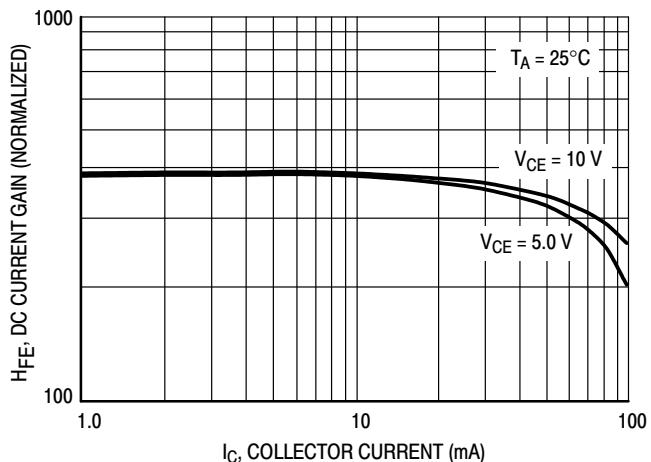


Figure 44. DC Current Gain - PNP

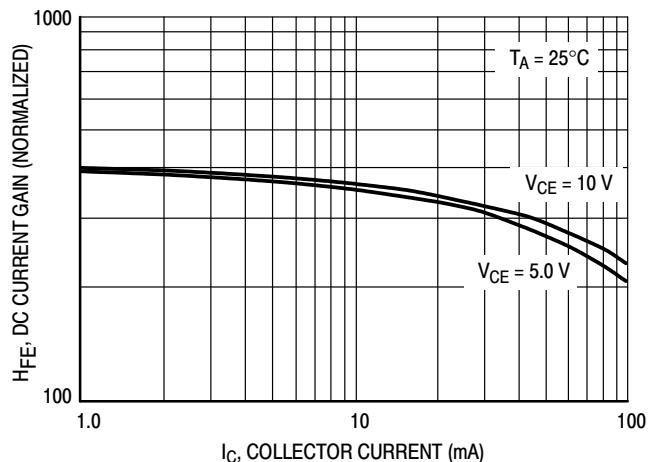


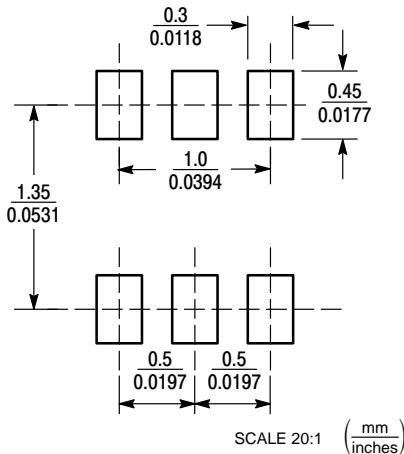
Figure 45. DC Current Gain - NPN

INFORMATION FOR USING THE SOT-563 SURFACE MOUNT PACKAGE

MINIMUM RECOMMENDED FOOTPRINT FOR SURFACE MOUNTED APPLICATIONS

Surface mount board layout is a critical portion of the total design. The footprint for the semiconductor packages must be the correct size to insure proper solder connection

interface between the board and the package. With the correct pad geometry, the packages will self align when subjected to a solder reflow process.



SOT-563

SOT-563 POWER DISSIPATION

The power dissipation of the SOT-563 is a function of the pad size. This can vary from the minimum pad size for soldering to a pad size given for maximum power dissipation. Power dissipation for a surface mount device is determined by $T_{J(max)}$, the maximum rated junction temperature of the die, $R_{\theta JA}$, the thermal resistance from the device junction to ambient, and the operating temperature, T_A . Using the values provided on the data sheet for the SOT-563 package, P_D can be calculated as follows:

$$P_D = \frac{T_{J(max)} - T_A}{R_{\theta JA}}$$

The values for the equation are found in the maximum ratings table on the data sheet. Substituting these values into the equation for an ambient temperature T_A of 25°C, one can calculate the power dissipation of the device which in this case is 150 milliwatts.

$$P_D = \frac{150^\circ\text{C} - 25^\circ\text{C}}{833^\circ\text{C/W}} = 150 \text{ milliwatts}$$

The 833°C/W for the SOT-563 package assumes the use of the recommended footprint on a glass epoxy printed circuit board to achieve a power dissipation of 150 milliwatts. There are other alternatives to achieving higher power dissipation from the SOT-563 package. Another alternative would be to use a ceramic substrate or an aluminum core board such as Thermal Clad®. Using a board material such as Thermal Clad, an aluminum core board, the power dissipation can be doubled using the same footprint.

SOLDERING PRECAUTIONS

The melting temperature of solder is higher than the rated temperature of the device. When the entire device is heated to a high temperature, failure to complete soldering within a short time could result in device failure. Therefore, the following items should always be observed in order to minimize the thermal stress to which the devices are subjected.

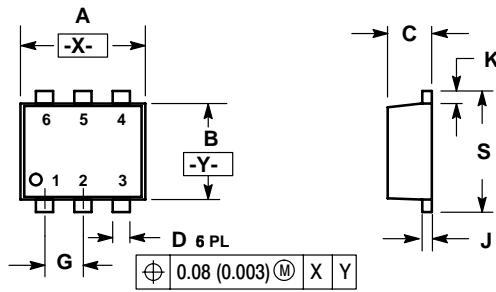
- Always preheat the device.
- The delta temperature between the preheat and soldering should be 100°C or less.*
- When preheating and soldering, the temperature of the leads and the case must not exceed the maximum temperature ratings as shown on the data sheet. When using infrared heating with the reflow soldering method, the difference shall be a maximum of 10°C.
- The soldering temperature and time shall not exceed 260°C for more than 10 seconds.
- When shifting from preheating to soldering, the maximum temperature gradient shall be 5°C or less.
- After soldering has been completed, the device should be allowed to cool naturally for at least three minutes. Gradual cooling should be used as the use of forced cooling will increase the temperature gradient and result in latent failure due to mechanical stress.
- Mechanical stress or shock should not be applied during cooling.

* Soldering a device without preheating can cause excessive thermal shock and stress which can result in damage to the device.

NSBC114EPDXV6T1, NSBC114EPDXV6T5

PACKAGE DIMENSIONS

SOT-563, 6 LEAD CASE 463A-01 ISSUE O



NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: MILLIMETERS
3. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL.

DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	1.50	1.70	0.059	0.067
B	1.10	1.30	0.043	0.051
C	0.50	0.60	0.020	0.024
D	0.17	0.27	0.007	0.011
G	0.50 BSC		0.020 BSC	
J	0.08	0.18	0.003	0.007
K	0.10	0.30	0.004	0.012
S	1.50	1.70	0.059	0.067

STYLE 1:

- PIN 1. Emitter 1
2. Base 1
3. Collector 2
4. Emitter 2
5. Base 2
6. Collector 1

STYLE 2:

- PIN 1. Emitter 1
2. Emitter2
3. Base 2
4. Collector 2
5. Base 1
6. Collector 1

STYLE 3:

- PIN 1. Cathode 1
2. Cathode 1
3. Anode/Anode 2
4. Cathode 2
5. Cathode 2
6. Collector 1

STYLE 4:

- PIN 1. Collector
2. Collector
3. Base
4. Emitter
5. Collector
6. Collector

NSBC114EPDXV6T1, NSBC114EPDXV6T5

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